

International Rectifier

Preliminary Data Sheet PD - 9.760

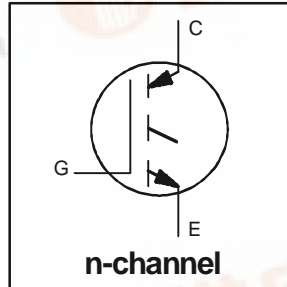
IRGPH50S

INSULATED GATE BIPOLAR TRANSISTOR

Standard Speed IGBT

Features

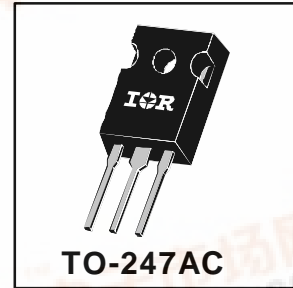
- Switching-loss rating includes all "tail" losses
- Optimized for line frequency operation (to 400Hz)
See Fig. 1 for Current vs. Frequency curve



$V_{CES} = 1200V$
$V_{CE(sat)} \leq 2.0V$
@ $V_{GE} = 15V, I_C = 33A$

Description

Insulated Gate Bipolar Transistors (IGBTs) from International Rectifier have higher usable current densities than comparable bipolar transistors, while at the same time having simpler gate-drive requirements of the familiar power MOSFET. They provide substantial benefits to a host of high-voltage, high-current applications.



Absolute Maximum Ratings

	Parameter	Max.	Units
V_{CES}	Collector-to-Emitter Voltage	1200	V
$I_C @ T_C = 25^\circ C$	Continuous Collector Current	57	A
$I_C @ T_C = 100^\circ C$	Continuous Collector Current	33	
I_{CM}	Pulsed Collector Current ①	110	
I_{LM}	Clamped Inductive Load Current ②	110	
V_{GE}	Gate-to-Emitter Voltage	± 20	V
E_{ARV}	Reverse Voltage Avalanche Energy ③	20	mJ
$P_D @ T_C = 25^\circ C$	Maximum Power Dissipation	200	W
$P_D @ T_C = 100^\circ C$	Maximum Power Dissipation	78	
T_J	Operating Junction and Storage Temperature Range	-55 to +150	$^\circ C$
T_{STG}			
	Soldering Temperature, for 10 sec.	300 (0.063 in. (1.6mm) from case)	
	Mounting torque, 6-32 or M3 screw.	10 lbf•in (1.1N•m)	

Thermal Resistance

	Parameter	Min.	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	—	—	0.64	$^\circ C/W$
$R_{\theta CS}$	Case-to-Sink, flat, greased surface	—	0.24	—	
$R_{\theta JA}$	Junction-to-Ambient, typical socket mount	—	—	40	
W_t	Weight	—	6 (0.21)	—	g (oz)



Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(BR)CES}$	Collector-to-Emitter Breakdown Voltage	1200	—	—	V	$V_{GE} = 0V, I_C = 250\mu A$
$V_{(BR)ECS}$	Emitter-to-Collector Breakdown Voltage ④	20	—	—	V	$V_{GE} = 0V, I_C = 1.0A$
$\Delta V_{(BR)CES}/\Delta T_J$	Temperature Coeff. of Breakdown Voltage	—	1.3	—	V/°C	$V_{GE} = 0V, I_C = 1.0mA$
$V_{CE(on)}$	Collector-to-Emitter Saturation Voltage	—	1.7	2.0	V	$I_C = 33A$
		—	2.2	—		$I_C = 57A$
		—	2.0	—		$I_C = 33A, T_J = 150^\circ\text{C}$
$V_{GE(th)}$	Gate Threshold Voltage	3.0	—	5.5		$V_{CE} = V_{GE}, I_C = 250\mu A$
$\Delta V_{GE(th)}/\Delta T_J$	Temperature Coeff. of Threshold Voltage	—	-13	—	mV/°C	$V_{CE} = V_{GE}, I_C = 250\mu A$
g_{fe}	Forward Transconductance ⑤	—	19	—	S	$V_{CE} = 100V, I_C = 33A$
I_{CES}	Zero Gate Voltage Collector Current	—	—	250	μA	$V_{GE} = 0V, V_{CE} = 1200V$
		—	—	1000		$V_{GE} = 0V, V_{CE} = 1200V, T_J = 150^\circ\text{C}$
I_{GES}	Gate-to-Emitter Leakage Current	—	—	± 100	nA	$V_{GE} = \pm 20V$

Switching Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
Q_g	Total Gate Charge (turn-on)	—	72	108	nC	$I_C = 33A$
Q_{ge}	Gate - Emitter Charge (turn-on)	—	16	24		$V_{CC} = 400V$
Q_{gc}	Gate - Collector Charge (turn-on)	—	19	30		$V_{GE} = 15V$
$t_{d(on)}$	Turn-On Delay Time	—	62	—	ns	$T_J = 25^\circ\text{C}$
t_r	Rise Time	—	77	—		$I_C = 33A, V_{CC} = 960V$
$t_{d(off)}$	Turn-Off Delay Time	—	1200	1800		$V_{GE} = 15V, R_G = 5.0\Omega$
t_f	Fall Time	—	780	1200		Energy losses include "tail"
E_{on}	Turn-On Switching Loss	—	3.0	—	mJ	See Fig. 9, 10, 11, 14
E_{off}	Turn-Off Switching Loss	—	26	—		
E_{ts}	Total Switching Loss	—	29	44		
$t_{d(on)}$	Turn-On Delay Time	—	52	—	ns	$T_J = 150^\circ\text{C},$
t_r	Rise Time	—	76	—		$I_C = 33A, V_{CC} = 960V$
$t_{d(off)}$	Turn-Off Delay Time	—	1300	—		$V_{GE} = 15V, R_G = 5.0\Omega$
t_f	Fall Time	—	2100	—		Energy losses include "tail"
E_{ts}	Total Switching Loss	—	55	—	mJ	See Fig. 10, 14
L_E	Internal Emitter Inductance	—	13	—	nH	Measured 5mm from package
C_{ies}	Input Capacitance	—	1900	—	pF	$V_{GE} = 0V$
C_{oes}	Output Capacitance	—	140	—		$V_{CC} = 30V$
C_{res}	Reverse Transfer Capacitance	—	24	—		$f = 1.0MHz$

Notes:

- ① Repetitive rating; $V_{GE}=20V$, pulse width limited by max. junction temperature. (See fig. 13b)
- ② $V_{CC}=80\%(V_{CES}), V_{GE}=20V, L=10\mu H, R_G=5.0\Omega,$ (See fig. 13a)
- ③ Repetitive rating; pulse width limited by maximum junction temperature.
- ④ Pulse width $\leq 80\mu s$; duty factor $\leq 0.1\%$.
- ⑤ Pulse width 5.0 μs , single shot.

Refer to Section D - page D-13

Package Outline 3 - JEDEC Outline TO-247AC (TO-3P)